Application No. 10/723,491 Amendment dated November 28, 2006 In Response to non-final Office Action mailed August 28, 2006 Page 2 of 7

Amendment to the Claims

This listing of Claims will replace all prior versions, and listings, of claims in the application.

Listing of Claims

1. (Original) An exposure method for fabricating a liquid crystal display substrate, the method comprising the steps of:

aligning a reticle along a scanning direction, the reticle characterized by a reticle width and a reticle length and comprising a reticle pattern;

exposing the reticle pattern onto a portion of an exposure area on a substrate:

moving the substrate perpendicular to the scanning direction no greater than one-half of the reticle width; and

repeating the exposing and moving steps, thereby exposing an entirety of the exposure area at least twice.

- 2. (Original) The exposure method of claim 1, where the reticle length is at least as wide as the exposure area.
- 3. (Original) The exposure method of claim 1, where the exposing step is performed while the reticle and the substrate are moved simultaneously.
- 4. (Original) The exposure method of claim 3, where the reticle and the substrate are moved in the same direction.
- 5. (Original) The exposure method of claim 1, where the exposing step comprises the step of scanning the reticle along a longer axis direction of the reticle.

Application No. 10/723,491 Amendment dated November 28, 2006 In Response to non-final Office Action mailed August 28, 2006 Page 3 of 7

6. (Canceled)

- 7. (Original) The exposure method of claim 1, where the exposing step comprises illuminating along a length direction perpendicular to the scanning direction.
- 8. (Original) The exposure method of claim 1, where the reticle pattern is repetitive.
- 9. (Original) The exposure method of claim 1, where the exposing step comprises the step of equimultiple erect imaging to transcribe the reticle pattern onto the exposure region in 1:1 proportion.
- 10. (Original) The exposure method of claim 1, wherein the moving step comprises the step of moving the substrate approximately one-half of the reticle width.
- 11. (Withdrawn) An exposure apparatus for exposing a reticle onto an exposure area of a substrate, the apparatus comprising:

a mask stage for supporting a reticle comprising a reticle pattern, the reticle pattern characterized by a reticle width, a reticle length, and a scanning direction;

a substrate stage for supporting an LCD substrate comprising an exposure area, the substrate stage moving the LCD substrate perpendicular to the scanning direction no greater than one-half of the reticle width between exposures of the reticle; and

Application No. 10/723,491 Amendment dated November 28, 2006 In Response to non-final Office Action mailed August 28, 2006 Page 4 of 7

an illuminative optical system for exposing the reticle pattern along the scanning direction onto a portion of the exposure area,

the substrate stage and illuminative optical system repeatedly moving and exposing to expose an entirety of the exposure area at least twice.

- 12. (Withdrawn) The exposure apparatus of claim 11, where the reticle length is longer than the reticle width and where the scanning direction is along the reticle length.
- 13. (Withdrawn) The exposure apparatus of claim 11, where the reticle pattern is repetitive.
- 14. (Withdrawn) The exposure apparatus of claim 11, where the substrate stage moves the substrate perpendicular to the scanning direction approximately one-half of the reticle width so that the entirety of the exposure area is exposed twice.
- 15. (Withdrawn) The exposure apparatus of claim 11, where the substrate stage moves the substrate perpendicular to the scanning direction less than one-half of the reticle width so that the entirety of the exposure area is exposed more than twice.
- 16. (Withdrawn) The exposure apparatus of claim 11, where the illuminative optical system is an equimultiple erect optical system.
- 17. (Withdrawn) The exposure apparatus of claim 11, where the reticle length is at least as wide as the exposure area.

Application No. 10/723,491 Amendment dated November 28, 2006 In Response to non-final Office Action mailed August 28, 2006 Page 5 of 7

- 18. (Withdrawn) The exposure apparatus of claim 11, where the reticle and the LCD substrate move together.
- 19. (Withdrawn) An exposure apparatus for exposing a reticle onto an exposure area of a substrate, the apparatus comprising:

a substrate stage for moving a substrate along an X-axis and a Y-axis that is perpendicular to the X-axis;

a mask stage for moving a reticle along the Y-axis; and an illuminative optical system for taking a plurality of exposures of the reticle along the Y-axis onto an exposure region on the substrate.

the mask stage moving the substrate along the X-axis in order to expose an entirety of the exposure region at least twice.

- 20. (Withdrawn) The exposure apparatus of claim 19, where the reticle is characterized by a reticle width and a reticle length, the reticle length disposed along the Y-axis and greater than the reticle width.
- 21. (Withdrawn) The exposure apparatus of claim 19, where the reticle comprises a repetitive reticle pattern.
- 22. (Withdrawn) The exposure apparatus of claim 19, where the mask stage moves the substrate along the X-axis in order to expose an entirety of the substrate twice.
- 23. (Withdrawn) The exposure apparatus of claim 22, where the reticle is characterized by a reticle width, and where the mask stage moves the substrate along the X-axis by approximately one-half of the reticle width.

Application No. 10/723,491 Amendment dated November 28, 2006 In Response to non-final Office Action mailed August 28, 2006 Page 6 of 7

- 24. (Withdrawn) The exposure apparatus of claim 19, where the mask stage moves the substrate along the X-axis in order to expose an entirety of the substrate more than twice.
- 25. (Withdrawn) The exposure apparatus of claim 24, where the reticle is characterized by a reticle width, and where the mask stage moves the substrate along the X-axis by less than one-half of the reticle width.
- 26. (Withdrawn) The exposure apparatus of claim 19, where the illuminative optical system scans the reticle along the Y-axis.
- 27. (Withdrawn) The exposure apparatus of claim 19, where the substrate and reticle move together along the Y-axis.
- 28. (Withdrawn) The exposure apparatus of claim 27, where the substrate and reticle move together along the Y-axis during exposure at the same speed.
- 29. (Withdrawn) The exposure apparatus of claim 19, where the illuminative optical system generates an illumination region of the reticle comprising a length direction perpendicular to the Y-axis.
- 30. (Withdrawn) The exposure apparatus of claim 19, where the reticle is at least as long as the exposure region along the Y-axis.